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# PBSS5160DS

# 60 V, 1 A PNP/PNP low V<sub>CEsat</sub> (BISS) transistor Rev. 03 — 9 October 2008

**Product data sheet** 

## **Product profile**

### 1.1 General description

PNP/PNP low V<sub>CEsat</sub> Breakthrough In Small Signal (BISS) transistor pair in a small SOT457 (SC-74) Surface-Mounted Device (SMD) plastic package.

NPN complement: PBSS4160DS.

#### 1.2 Features

- Low collector-emitter saturation voltage V<sub>CEsat</sub>
- High collector current capability I<sub>C</sub> and I<sub>CM</sub>
- High collector current gain (h<sub>FE</sub>) at high I<sub>C</sub>
- High efficiency due to less heat generation
- Smaller required Printed-Circuit Board (PCB) area than for conventional transistors

## 1.3 Applications

- Dual low power switches (e.g. motors, fans)
- Automotive applications

#### 1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{CEO}$	collector-emitter voltage	open base	-	-	-60	V
I <sub>C</sub>	collector current		<u>[1]</u> -	-	-1	Α
I <sub>CM</sub>	peak collector current	single pulse; $t_p \le 1 \text{ ms}$	-	-	-2	Α
R <sub>CEsat</sub>	collector-emitter saturation resistance	$I_{C} = -1 A;$ $I_{B} = -100 \text{ mA}$	[2] -	250	330	mΩ

<sup>[1]</sup> Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.

[2] Pulse test:  $t_p \le 300 \ \mu s; \ \delta \le 0.02.$ 



## 2. Pinning information

Table 2. Pinning

Table 2.	Filling		
Pin	Description	Simplified outline	Graphic symbol
1	emitter TR1	D. D. D.	2 5 4
2	base TR1	<u>    6   5   4   </u>	6 5 4
3	collector TR2	0	TR2
4	emitter TR2	1 1 2 13	(TR1)
5	base TR2		
6	collector TR1		1 2 3
			sym018

# 3. Ordering information

Table 3. Ordering information

Type number	Package	Package			
	Name	Description	Version		
PBSS5160DS	SC-74	plastic surface-mounted package (TSOP6); 6 leads	SOT457		

# 4. Marking

Table 4. Marking codes

Type number	Marking code
PBSS5160DS	A5

# 5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

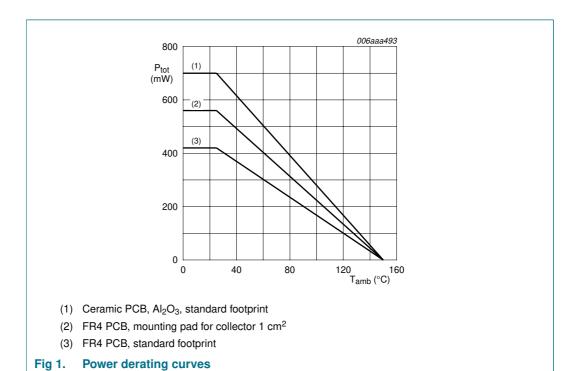
Symbol	Parameter	Conditions	Min	Max	Unit
Per transi	stor				
$V_{CBO}$	collector-base voltage	open emitter	-	-80	V
$V_{CEO}$	collector-emitter voltage	open base	-	-60	V
$V_{EBO}$	emitter-base voltage	open collector	-	<b>-</b> 5	V
I <sub>C</sub>	collector current		<u>[1]</u> -	-0.77	Α
			[2] _	-0.9	Α
			[3] _	-1	Α
I <sub>CM</sub>	peak collector current	single pulse; t <sub>p</sub> ≤ 1 ms	-	-2	Α
I <sub>B</sub>	base current		-	-300	mA
I <sub>BM</sub>	peak base current	single pulse; t <sub>p</sub> ≤ 1 ms	-	-1	Α

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**Table 5.** Limiting values ...continued In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
P <sub>tot</sub>	total power dissipation	$T_{amb} \le 25  ^{\circ}C$	<u>[1]</u> -	290	mW
			[2] -	370	mW
			[3] _	450	mW
Per device	e				
P <sub>tot</sub> total power dissipation	T <sub>amb</sub> ≤ 25 °C	<u>[1]</u> -	420	mW	
			[2] -	560	mW
			[3] _	700	mW
Tj	junction temperature		-	150	°C
T <sub>amb</sub>	ambient temperature		-65	+150	°C
T <sub>stg</sub>	storage temperature		-65	+150	°C

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.
- [3] Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.

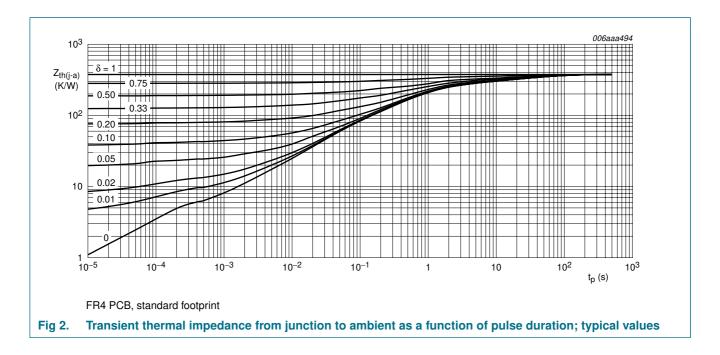


## 6. Thermal characteristics

Table 6. Thermal characteristics

idbic o.	memar characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Per transi	istor					
$R_{th(j-a)}$	thermal resistance from	in free air	<u>[1]</u> _	-	431	K/W
	junction to ambient		[2]	-	338	K/W
			[3]	-	278	K/W
$R_{th(j\text{-sp})}$	thermal resistance from junction to solder point		-	-	105	K/W
Per devic	е					
R <sub>th(j-a)</sub>	thermal resistance from	in free air	<u>[1]</u> -	-	298	K/W
	junction to ambient		[2] _	-	223	K/W
			[3] _	-	179	K/W
-						

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.
- [3] Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.



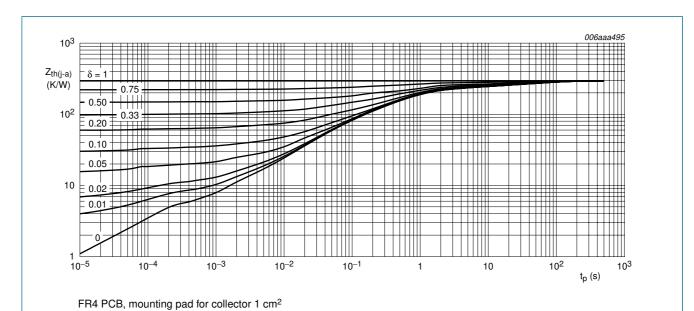


Fig 3. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

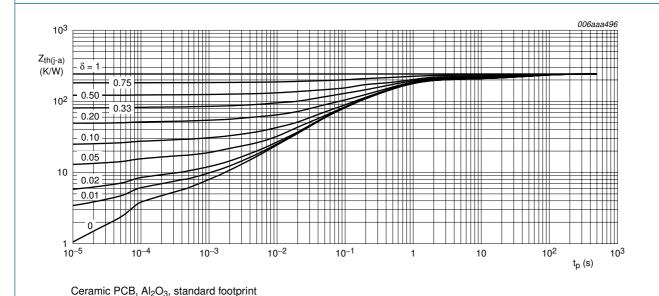


Fig 4. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

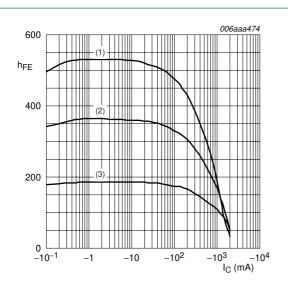
## 7. Characteristics

Table 7. Characteristics

T<sub>amb</sub> = 25 °C unless otherwise specified.

	Duriness otherwise spec			-	14.	11.71
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Per trans	istor					
$I_{CBO}$	collector-base cut-off	$V_{CB} = -60 \text{ V}; I_E = 0 \text{ A}$	-	-	-100	nA
	current	$V_{CB} = -60 \text{ V}; I_E = 0 \text{ A};$ $T_j = 150 ^{\circ}\text{C}$	-	-	<b>-50</b>	μΑ
I <sub>CES</sub>	collector-emitter cut-off current	$V_{CE} = -60 \text{ V}; V_{BE} = 0 \text{ V}$	-	-	-100	nA
I <sub>EBO</sub>	emitter-base cut-off current	$V_{EB} = -5 \text{ V}; I_C = 0 \text{ A}$	-	-	-100	nA
h <sub>FE</sub>	DC current gain	$V_{CE} = -5 \text{ V}; I_{C} = -1 \text{ mA}$	200	350	-	
		$V_{CE} = -5 \text{ V}; I_{C} = -500 \text{ mA}$	<u>11</u> 150	250	-	
		$V_{CE} = -5 \text{ V}; I_{C} = -1 \text{ A}$	100	160	-	
V <sub>CEsat</sub>	collector-emitter	$I_C = -100 \text{ mA}; I_B = -1 \text{ mA}$	-	-110	-165	mV
saturation voltage	$I_C = -500 \text{ mA}; I_B = -50 \text{ mA}$	-	-120	-175	mV	
	$I_C = -1 A$ ; $I_B = -100 \text{ mA}$	[1] -	-250	-330	mV	
V <sub>BEsat</sub>	base-emitter saturation voltage	$I_C = -1 A$ ; $I_B = -50 \text{ mA}$	<u>[1]</u> -	-0.95	-1.1	V
R <sub>CEsat</sub>	collector-emitter saturation resistance	$I_C = -1 A$ ; $I_B = -100 \text{ mA}$	[1] -	250	330	mΩ
$V_{BEon}$	base-emitter turn-on voltage	$I_C = -1 A; V_{CE} = -5 V$	[1] -	-0.82	-0.9	V
t <sub>d</sub>	delay time	$I_C = -0.5 \text{ A}$ ; $I_{Bon} = -25 \text{ mA}$ ;	-	11	-	ns
t <sub>r</sub>	rise time	$I_{Boff} = 25 \text{ mA}$	-	30	-	ns
t <sub>on</sub>	turn-on time		-	41	-	ns
t <sub>s</sub>	storage time		-	205	-	ns
t <sub>f</sub>	fall time		-	55	-	ns
t <sub>off</sub>	turn-off time		-	260	-	ns
f <sub>T</sub>	transition frequency	$V_{CE} = -10 \text{ V}; I_{C} = -50 \text{ mA};$ f = 100 MHz	150	185	-	MHz
C <sub>c</sub>	collector capacitance	$V_{CB} = -10 \text{ V}; I_E = i_e = 0 \text{ A};$ f = 1 MHz	-	9	15	pF

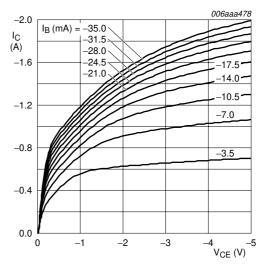
<sup>[1]</sup> Pulse test:  $t_p \leq 300~\mu s;~\delta \leq 0.02.$ 



$$V_{CE} = -5 \text{ V}$$

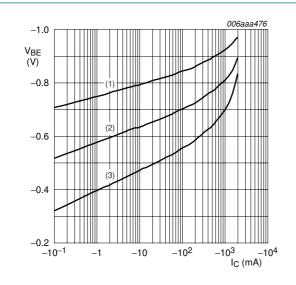
- (1)  $T_{amb} = 100 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = -55 \, ^{\circ}C$

Fig 5. DC current gain as a function of collector current; typical values



T<sub>amb</sub> = 25 °C

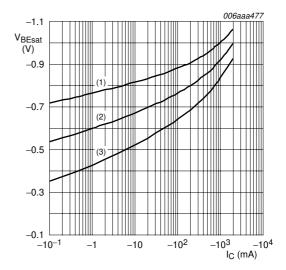
Fig 6. Collector current as a function of collector-emitter voltage; typical values





- (1)  $T_{amb} = -55 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = 100 \, ^{\circ}C$

Fig 7. Base-emitter voltage as a function of collector current; typical values

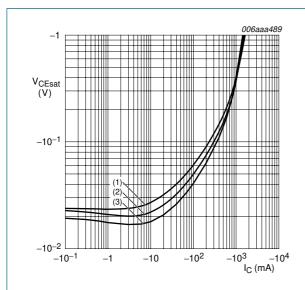


 $I_{\rm C}/I_{\rm B} = 20$ 

- (1)  $T_{amb} = -55 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = 100 \, ^{\circ}C$

Fig 8. Base-emitter saturation voltage as a function of collector current; typical values

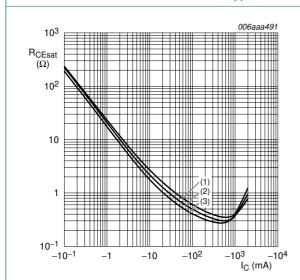
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$$I_{\rm C}/I_{\rm B} = 20$$

- (1)  $T_{amb} = 100 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = -55 \, ^{\circ}C$

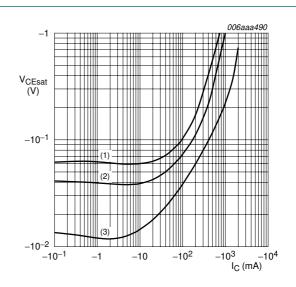
Fig 9. Collector-emitter saturation voltage as a function of collector current; typical values



$$I_{\rm C}/I_{\rm B} = 20$$

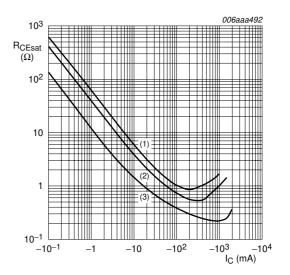
- (1)  $T_{amb} = 100 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = -55 \,^{\circ}C$

Fig 11. Collector-emitter saturation resistance as a function of collector current; typical values



- (1)  $I_C/I_B = 100$
- (2)  $I_C/I_B = 50$
- (3)  $I_C/I_B = 10$

Fig 10. Collector-emitter saturation voltage as a function of collector current; typical values



$$T_{amb} = 25 \, ^{\circ}C$$

- (1)  $I_C/I_B = 100$
- (2)  $I_C/I_B = 50$
- (3)  $I_C/I_B = 10$

Fig 12. Collector-emitter saturation resistance as a function of collector current; typical values

## 8. Test information

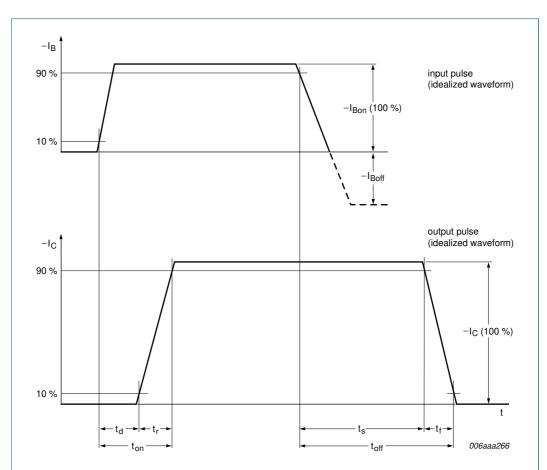
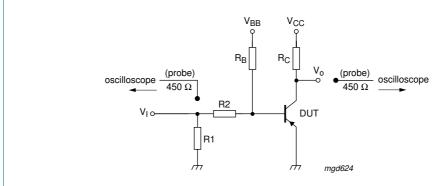


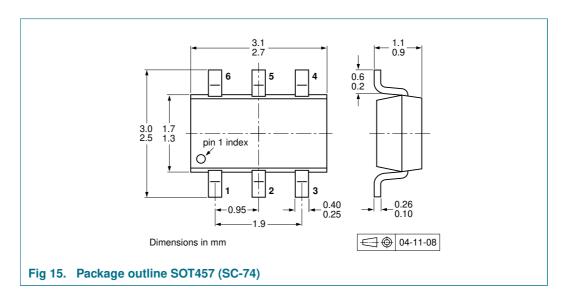
Fig 13. BISS transistor switching time definition



 $I_C$  = -0.5 A;  $I_{Bon}$  = -25 mA;  $I_{Boff}$  = 25 mA; R1 = open; R2 = 100  $\Omega$ ;  $R_B$  = 300  $\Omega$ ;  $R_C$  = 20  $\Omega$ 

Fig 14. Test circuit for switching times

## 9. Package outline



# 10. Packing information

Table 8. Packing methods

The indicated -xxx are the last three digits of the 12NC ordering code.[1]

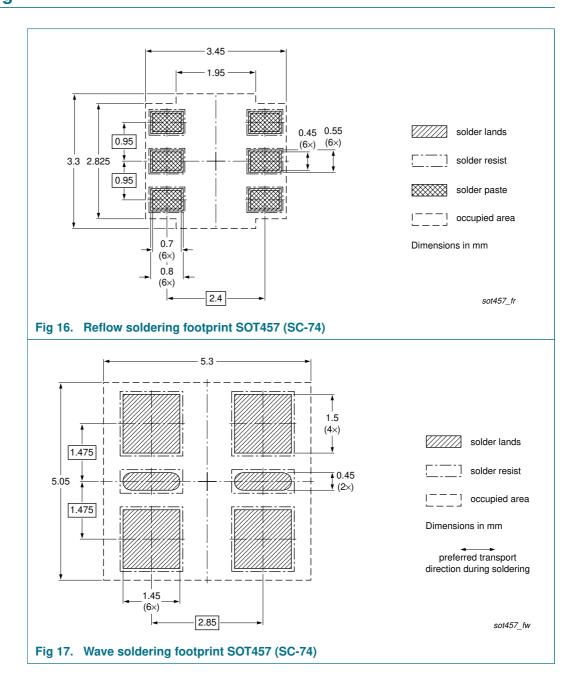
Type number	Package	Description		Packing quantity	
				3000	10000
PBSS5160DS	SOT457	4 mm pitch, 8 mm tape and reel; T1	[2]	-115	-135
		4 mm pitch, 8 mm tape and reel; T2	[3]	-125	-165

[1] For further information and the availability of packing methods, see Section 14.

[2] T1: normal taping

[3] T2: reverse taping

## 11. Soldering



# 12. Revision history

#### Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PBSS5160DS_3	20081009	Product data sheet	-	PBSS5160DS_2
Modifications:	guidelines o	of NXP Semiconductors.	s data sheet has been redesigned to comply with the new identity P Semiconductors.	
	<ul> <li>Legal texts have been adapted to the new company name where appropriate.</li> </ul>			
	<ul> <li>Figure 9: an</li> </ul>	nended		
	<ul> <li>Section 13 <sup>c</sup></li> </ul>	<u>'Legal information"</u> : updated	l	
PBSS5160DS_2	20050628	Product data sheet	-	PBSS5160DS_1
PBSS5160DS_1	20040716	Objective data sheet	-	-

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#### 13.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <a href="http://www.nxp.com">http://www.nxp.com</a>.

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